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CLAIMS

- 1. An apparatus for controlling flow rate of gases used in semiconductor device fabrication by differential pressure, comprising:
- a body having a flow passage for the gas used in the semiconductor device fabrication;
- a control valve for controlling a flow of the gas by opening or closing the flow passage of the body;
- a differential pressure generation element installed in the flow passage of the body to generate differential pressure;
 - a tube installed to penetrate through the differential pressure generation element;
 - a pressure sensor received in the tube to detect the differential pressure in the flow passage generated by the differential pressure generation element; and
- a central processing unit for calculating the flow rate of the gas according to a detection signal input from the pressure sensor and controlling the control valve.
 - 2. The apparatus as claimed in claim 1, wherein the differential pressure generation element comprises a porous material.
- 20 3. The apparatus as claimed in claim 2, wherein the tube is installed to penetrate through the center of the porous material.
 - 4. The apparatus as claimed in claim 1, wherein the differential pressure generation element comprises a porous material having a first vertical plate portion vertically abutting on a lower wall surface of the flow passage, a horizontal plate portion horizontally extending from a downstream end of the first vertical plate portion, and a second vertical plate portion vertically extending from a downstream end of the horizontal plate portion and abutting on an upper wall surface of the flow passage.
- 30 5. The apparatus as claimed in claim 4, wherein the tube is installed at the horizontal

plate portion of the porous material to penetrate therethrough perpendicularly to a flow direction of the gas, and the pressure sensor is horizontally received in the tube.

6. The apparatus as claimed in claim 1, wherein the differential pressure generation element comprises a plurality of capillary tubes installed along a flow direction of the gas.

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